Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/533,918	OZAWA ET AL.	
Examiner	**Art Unit**	
Nguyen T. Ha	2831	

SEARCHED			
Class	Subclass	Date	Examiner
361	523-525	2/26/2007	NH
	527-534		
	516-519		
29	25.01		
	25.03		
252	62.2		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH (SEE SEARCH HISTORY)	2/26/2007	NH